

<b>Notice of References Cited</b>	Application/Control No. 10/675,664	Applicant(s)/Patent Under Reexamination NIEDERDRANK, TORSTEN	
	Examiner Brian Ensey	Art Unit 2615	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,862,436	03-2005	Hayakawa et al.	455/82
*	B	US-5,768,690	06-1998	Yamada et al.	455/83
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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